Status of the Front Tracker GEM and INFN Electronics

2013 – Feb – 20

SBS Weekly Meeting

INFN – Catania, Genova, Bari and Rome

GEM Assembling

SRS – INFN Electronics comparison

Electronics Status

GEM HV Conditioning-Test

Fast rump-up at 550 V,

- July, July, Sparks in the first few seconds (current of 'imit at 2uA) «Cleaning» sparks in the
- Stay at 550 V for about 40 s (if no additional sparks)
- Rump-down at 450 V, stay till stabilize.

Measured current: << 1 nA @ 450 V / sector (raw GEM)



The new GEM foils passed the RUI-like/conditioning-test

12/Dec/2012

SBS-Meeting

Time (s)

GEM Assembling

First module assembled; mylar window glued last Monday. Gas and HV system under installation.



12/Dec/2012

APV cards tested

All cards read by the INFN-MPD (APV controller and ADC unit)

INFN-APVs use a backplane to connect to the MPD.

INFN-APVs need flat adapter to connect to CERN chambers



Flat adapter to Panasonic connector Backplane Flat adapter to Panasonic connector SRS-card SRS-MPD adapter (wiring only)

INFN – SRS/Card disconnected



RMS of pedestals very similar and consistent with UVa SRS measurement

12/Dec/2012

SBS-Meeting

INFN – SRS/Card disconnected: internal pulser



SRS slightly higher gain, but probably within cards variability

SBS-Meeting

INFN – SRS: external pulse - setup





Flat adapter behaves like antenna

RMS

Cards disconnected

0 52 11.5922 5.02732 (under test) 0 54 7.85821 3.22162 (ref) 0 78 7.23681 0.735929 (SRS disconnected)

 INFN card connected to flat adapter and test board

 1 52
 21.3011
 5.53139

 1 54
 7.90626
 3.21417 (ref)

 1 78
 7.24934
 0.687134

Test board powered (no pulse)2 52205.5042 547.884133.1347 (ref)2 787.214770.693002

Improved grounding 3 52 33.3747 8.43939 3 54 7.87384 3.18852 (reF) 3 78 7.21792 0.684405

Adapter disconnected from test board (picture above) 4 52 28.792 6.532 4 54 7.9133 3.176 (ref) 4 78 7.2743 0.312

No adapter, test board above APV (picture below) 5 52 9.7645 4.583 5 54 8.1423 3.246 (ref) 5 78 7.3087 0.328



INFN – SRS : int/ext test summary

- Noise levels of "naked" cards look very similar and consistent with UVa
- Noise levels when cards are connected to test board changes -> we found an effect of the flexible adapter
- Gain with internal pulse very similar
- Gain with external pulse factor of 2 better in SRS (consider different input capacitance that explain part of the gap)
- The hardware differences identified up-to-now do not explain difference in sensitivity

INFN card more sensitive to noise than SRS (when connected).

10x10 CERN GEM Chamber setup



Chamber Setup

- 4 INFN- cards: 2 connected to the "x" axis, 2 as reference
- 1 SRS card connected to the "y" axis
- All cards read simultaneously with identical software settings
- CREMAT preamp to the upper layer of the GEM foil facing the readout plane (+ low pass filter)

Voltage divider a la COMPASS

Pedestal and Noise, SRS not conn.



Confirm SRS and INFN card noise equivalent with disconnected cards

Pedestal and Noise, cards connected



Larger noise when INFN cards are connected respect to SRS

Noise measurements on chamber

All connected (51, 54 always disconnected, 62 SRS)

51 0 8.36366 3.15819 52 0 21.4899 5.41732 53 0 22.0336 4.68268 54 0 7.47843 3.10985 62 0 13.9927 4.54739

SRS disconnected

51 0 8.40966 3.15261 52 0 18.9219 4.8044 53 0 17.6065 5.3753 54 0 7.53835 3.14959 62 0 6.93804 1.25661

<u>One INFN card disconnected</u> 51 0 8.35581 3.15129 52 0 30.5165 11.6532 53 0 11.735 6.7953 54 0 7.44862 3.1477 62 0 13.5801 3.29789

All INFN cards disconnected (SRS connected to chamber) 51 0 8.52771 3.38525 52 0 9.97818 4.19041 53 0 11.9473 7.0925 54 0 7.52595 3.27819 62 0 17.2399 4.84427 <u>As before, muxgain=4</u> 51 0 12.2671 4.97137

52 0 33.6612 9.04412 53 0 34.8818 8.63826 54 0 10.6839 4.76459 62 0 19.7942 6.01776 When connected to chamber: INFN: 21-22 ADC unit SRS: 13-14 ADC unit

When disconnected: INFN: 7-8 (no adapter) INFN: 11-12 (with adapter) SRS: 7

(muxgain=1, adc.gain=5)

55Fe CREAM pream output

Signal clearly visible

Horizontal chamber layout improved (respect to vertical) noise significiantly (in Rome LAB)

But noise still large!



The chamber "itself" seems to be noisy (environment ...)

55Fe - First plots on cluster charge



MPD v4 (from Paolo)

Hardware modifications made on MPD v 4.0

- * Removed 2 input and 2 outputs on front panel (LEMO)
- * Removed USB interface
- * Removed FLASH Eprom
- * Moved from 2 x HDMI-B to 4 x HDMI-A for analog connections
- * Added micro SD-card slot
- * Added analog MUX (ADG619) to select output levels (NIM/LVTTL)
- * Added front panel LEMO for external clock (40 MHz, LVTTL, 50 ohm terminated)
- * Moved local oscillator from 100 MHz to 40 MHz for front panel clock frequency compatibility
- * Moved from PCA9506 to PCA9517 for external I2C buffering
- * Added 2 x Molex 71439-0164 piggy back connectors PMC compliant
- * Moved from DDR (2 x MT46V64M8P-6T:F) to DDR2 (1 x MT47H128CF-3:H) memory, always 128 MB
- * Moved from single ended (LVTTL) to differential (LVDS) for clock to ADC and APV.
- * Set DELAY25 to work in LVDS mode.
- * Added 120 ohm termination to analog signals at the ADC inputs
- * Used the same connections for ADC (ADS5281) as in RD51, except for equalization network which has not been implemented
- * Used 65LVDS104 as repeaters for APV clocks
- * Used 65LVDS105 as translators for APV triggers
- * Added inductors for better separation of 1.8 V supply between ADC, FPGA and DDR2
- * Moved FPGA symbol to EP1AGX50. The effective FPGA adopted will be a EP1AGX60F780

Performed DDR2 simulations: behavioral (ModelSim) and board levels (HyperLynx)

Run QUARTUS to implement FPGA with DDR2 interface: DDR timing analysis is good up to 220 MHz

Performed HyperLynx simulations for critical signals: ADC and APV clocks. Models for DELAY25 and ADS5281 are derived from Altera LVDS ibis.

Work in progress

 Continue work with 55Fe on small chamber (reduce noise of pream !!) and on front-end electronics

- First module to be delivered in Rome for measurements

- Start assembling of second module

- MPD v4, 2 boards under production